Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/677,370	TAKAHASHI ET AL.	
Examiner	Art Unit	

2861

Lamson D. Nguyen

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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